

Application No.	Applicant(s)
10/717,406	ZHAN ET AL.
Examiner	Art Unit
Toan M. Le	2863

SEARCHED				
Class	Subclass	Date	Examiner	
702	35	4/20/2005	TL	
73	861.356	4/20/2005	TL	
73	1.72	4/20/2005	TL	
703	5	4/20/2005	TL	
703	9	4/20/2005	TL	
702	47	4/20/2005	TL	
702	100	4/20/2005	TL	
700	282	4/20/2005	TL	
Above	Updated	10/7/2005	TL	
Above	Updated	7/16/2006	TL	

INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner		

SEARCH NO (INCLUDING SEARCH)
	DATE	EXMR
Wavelet Singularity Detection	4/20/2005	TL
Wavelet Valve	4/20/2005	TL
Valve Wavelet Decomposition	4/20/2005	TL
Valve Regulator Flow Wavelet	4/20/2005	TL
Valve Defect Wavelet	4/20/2005	TL
702/35,47,100; 73/861.356,1.72; 703/5,9; 700/282 (Decomposing Resolution Defect Valve)	7/16/2006	TL
East- See Search History Printout	7/16/2006	TL